## SPECIALIA

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## X-Ray Research of Polycrystals. X-Ray Diffraction Methods for Precision Determinations of Polycrystal Lattice Parameters over Unsolved Double Lines

The present report considers the possibility of the precise determination of lattice parameters over unsolved and partially solved double lines. The determination of lattice parameters were carried out in this case using 2 points of a diffractional line profile – the middle of a width and the weights-centre. The wave-lengths, corresponding to the above points of the profile of a spectral distribution curve, were used. The values of the wavelengths were estimated by formulae:

(a) for the point of a weights-centre:

$$\lambda_{\alpha b} = \frac{J_1 \, \lambda_{\alpha_1 b} + J_2 \, \lambda_{\alpha_2 b}}{J_1 + J_2} \, .$$

(b) for the point of a middle width:

$$\lambda_{\alpha av} = \frac{J_1 \lambda_{\alpha_1 av} + J_2 \lambda_{\alpha_2 av}}{J_1 + J_2}.$$

Where  $J_1$  and  $J_2$  are the relative intensities of the components  $\alpha_1$  and  $\alpha_2$  of a doublet,  $\lambda_{\alpha_i b}$  and  $\lambda_{\alpha_i a v}$  (i = 1.2) are found from the formulae<sup>1</sup>.

The preparation of specimens, exposition and evaluation of angles was carried out as in our earlier work <sup>1</sup>. The parameter of the crystallic lattice of armco-iron was determined over the unsolved double line (2II), using  $Cr\ K_{\alpha}$ -radiation. The mean values of the parameters, estimated over the points of the middle of a width and a weights-centre are equal to 2.86596  $\pm$  0.00008 Å and 2.86599  $\pm$  0.00023 Å, accordingly.

In the case of a partially solved double line, we suggest the following method of the location of a middle-width point.

- (1) The lines parallel to the background line are to be drawn through the middle of the height of each component of a doublet.
- (2) The segment of a height between these 2 lines is to be divided in ratio  $J_2:J_1 (\approx 1:2)$ .
- (3) The line parallel to the background line is to be drawn through the above point. The middle of the line obtained is the point to be found.

The lattice parameter of tungsten (W) of 99.95% purity was determined over the middle of the width of the partially solved double line (400), using Cu  $K_{\alpha}$ -radiation. The mean value of the parameter, corrected to 25 °C and for refraction, is equal to 3.16531  $\pm$  0.00008 Å. The lattice parameter of tungsten (W), determined over (420)  $\beta$ -like, is equal to 3.16534  $\pm$  0.00005 Å.

Выводы. Предложена методика рентгенографического прецизионного определения параметров решетки поликристаллов по неразрешенным дублетным линиям. Проведена экспериментальная проверка метода на образцах армко-железа и вольфрама.

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<sup>1</sup> G. V. DAVYDOV, V. P. DZEKANOVSKAYA and N. A. EROKHOV, Experientia 23, 349 (1967).

## X-Ray Research of Polycrystals. The Methods for Approximation at Determination of the Real Width of X-Ray Interferentional Lines with the Application of a Standard-Sample

According to the suggested approximating function for the profiles of diffractional lines <sup>1</sup>

$$\varphi(x) = \alpha \, x^{\gamma} \exp\left(-\varepsilon \, x\right)$$

and using the definition of a line width

$$B = \frac{\int\limits_{0}^{\infty} \varphi(x) \ dx}{\varphi(x_m)}$$

it is easy to obtain an expression for the absolute meaning of B:

$$B = \frac{c \sqrt{\gamma}}{c} (c \approx \sqrt{2 \pi}). \tag{1}$$

It is possible to obtain an expression for the physical broadening of a line due to the blocks dispersity and the second kind of tensions, supposing that the profile of a considered line is described by the function  $h(x) = \alpha$ ,  $x^{\gamma_1} \exp(-\varepsilon, x)$ , and the profile of a standard line – by the function  $f(x) = \alpha_2 x^{\gamma_2} \exp(-\varepsilon_2 x)$ . Then

$$\beta = \frac{\gamma_2 \, \varepsilon_1 + \varepsilon_2}{\varepsilon_1 \, (\varepsilon_2 - \varepsilon_1)} \, \exp(\varepsilon_1 \, \xi_m) \tag{2}$$

where

$$\xi_m = \frac{\varepsilon_2 - \varepsilon_1 (\gamma_2 + 2)}{\varepsilon_1 (\varepsilon_2 - \varepsilon_1)}$$
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<sup>1</sup> G. V. DAVYDOV, N. A. Erokhov and G. F. Belyaeva, Experientia 23, 352 (1967).